MOSFET – Power, N-Channel, SO-8 30 V, 18 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- This is a Pb-Free Device

Applications

- DC-DC Converters
- Synchronous MOSFET
- Printers

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Paran | Symbol | Value | Unit | | |
|--|--------------------|---------------------------|--------------------------------------|---------------|----|
| Drain-to-Source Voltage | V_{DSS} | 30 | V | | |
| Gate-to-Source Voltage | | | V_{GS} | ±20 | V |
| Continuous Drain | | T _A = 25°C | I _D | 15 | Α |
| Current R _{θJA} (Note 1) | | T _A = 70°C | | 12 | |
| Power Dissipation $R_{\theta JA}$ (Note 1) | | T _A = 25°C | P _D | 1.66 | W |
| Continuous Drain | | T _A = 25°C | I _D | 11.1 | Α |
| Current R _{θJA} (Note 2) | Steady | T _A = 70°C | | 8.9 | |
| Power Dissipation $R_{\theta JA}$ (Note 2) | State | T _A = 25°C | P _D | 0.91 | W |
| Continuous Drain | | T _A = 25°C | I _D | 18 | Α |
| Current $R_{\theta JA}$, $t \le 10 s$ (Note 1) | | T _A = 70°C | | 15 | |
| Power Dissipation $R_{\theta JA}$, $t \le 10 \text{ s(Note 1)}$ | | T _A = 25°C | P _D | 2.5 | W |
| Pulsed Drain Current | $T_A = 25^{\circ}$ | C, t _p = 10 μs | I _{DM} | 60 | Α |
| Operating Junction and Storage Temperature | | | T _J , T _{stg} | –55 to 150 | °C |
| Source Current (Body Did | IS | 2.5 | Α | | |
| Single Pulse Drain-to-So $(T_J = 25^{\circ}C, V_{DD} = 30 \text{ V}, V_{L} = 29 \text{ A}_{pk}, L = 1.0 \text{ mH}, F$ | E _{AS} | 420 | mJ | | |
| Lead Temperature for So (1/8" from case for 10 s) | TL | 260 | °C | | |

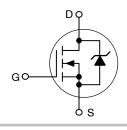


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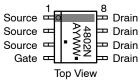
| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX | |
|----------------------|-------------------------|--------------------|--|
| 30 V | 4.0 mΩ @ 10 V | 18 A | |
| | 5.5 mΩ @ 4.5 V | 10 A | |

N-Channel





MARKING DIAGRAM/ PIN ASSIGNMENT



4802N = Device Code A = Assembly Location Y = Year

WW = Work Week
■ Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

| Device | Package | Shipping [†] |
|--------------|-------------------|-----------------------|
| NTMS4802NR2G | SO-8 (Pb-Free) | 2500/Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Ambient - Steady State (Note 1) | $R_{\theta JA}$ | 75.5 | °C/W |
| Junction-to-Ambient – $t \le 10 \text{ s (Note 1)}$ | $R_{\theta JA}$ | 50.5 | |
| Junction-to-Foot (Drain) | $R_{\theta JF}$ | 22 | |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 138 | |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surfacemounted on FR4 board using 1 in sq pad size.

2. Surfacemounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T₁ = 25°C unless otherwise specified)

| Parameter | Symbol | Test Condition | on | Min | Тур | Max | Unit |
|--|--------------------------------------|---|--------------------------|-----|------|------|-------|
| OFF CHARACTERISTICS | | | | | | • | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | $V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$ | | 30 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 26 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, V _{DS} = 24 V | T _J = 25°C | | | 1.0 | μΑ |
| | | $V_{GS} = 0 V$, $V_{DS} = 24 V$ | T _J = 85°C | | | 10 | 1 |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, V _{GS} = | ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 3) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D = 2$ | 250 μΑ | 1.0 | | 2.5 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 7.0 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V, I _D = 18 A | | | 3.2 | 4.0 | mΩ |
| | | V _{GS} = 4.5 V, I _D = 15 A | | | 4.3 | 5.5 | |
| Forward Transconductance | 9 _{FS} | V _{DS} = 1.5 V, I _D = 18 A | | | 55 | | S |
| CHARGES, CAPACITANCES AND G | ATE RESISTAN | ICE | | | | | |
| Input Capacitance | C _{iss} | V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 25 V | | | 5300 | | pF |
| Output Capacitance | C _{oss} | | | | 880 | | |
| Reverse Transfer Capacitance | C _{rss} | | | | 460 | | |
| Total Gate Charge | Q _{G(TOT)} | | | | 36 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 4.5 V, V _{DS} = 15 | \/ | | 6.5 | | |
| Gate-to-Source Charge | Q_{GS} | v _{GS} = 4.5 v, v _{DS} = 15 | v, I _D = 10 A | | 14 | | |
| Gate-to-Drain Charge | Q_{GD} | | | | 13 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 15 ' | V, I _D = 18 A | | 75 | | nC |
| SWITCHING CHARACTERISTICS (No | ote 4) | | | | | | |
| Turn-On Delay Time | t _{d(on)} | | | | 18 | | ns |
| Rise Time | t _r | V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 1.0 A, R_{G} = 6.0 Ω | | | 42 | | 7 |
| Turn-Off Delay Time | t _{d(off)} | | | | 70 | | |
| Fall Time | t _f | | | | 56 | | |
| DRAIN-SOURCE DIODE CHARACTE | RISTICS | | | | | | |
| Forward Diode Voltage | V_{SD} | V _{GS} = 0 V, I _S = 2.5 A | $T_J = 25^{\circ}C$ | | 0.7 | 1.0 | V |
| | | v _{GS} = 0 v, I _S = 2.5 A | T _J = 125°C | | 0.6 | | |

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

| Parameter | Symbol | Test Condition | Min | Тур | Max | Unit |
|--------------------------|-----------------|--|-----|------|-----|------|
| DRAIN-SOURCE DIODE CHARA | CTERISTICS | | • | | | |
| Reverse Recovery Time | t _{RR} | | | 40 | | ns |
| Charge Time | t _a | $V_{GS} = 0 \text{ V}, d_{IS}/d_{t} = 100 \text{ A}/\mu\text{s},$ | | 20 | | 1 |
| Discharge Time | t _b | $\begin{split} V_{GS} = 0 \ V, \ d_{IS}/d_t = 100 \ A/\mu s, \\ I_S = 2.5 \ A \end{split}$ | | 20 | | 1 |
| Reverse Recovery Charge | Q _{RR} | | | 40 | | nC |
| PACKAGE PARASITIC VALUES | | | | | | |
| Source Inductance | L _S | | | 0.66 | | nH |
| Drain Inductance | L _D | T 25°C | | 0.20 | | nH |
| Gate Inductance | L _G | $T_A = 25^{\circ}C$ | | 1.5 | | nH |
| Gate Resistance | R_{G} | | | 1.0 | 1.5 | Ω |

Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

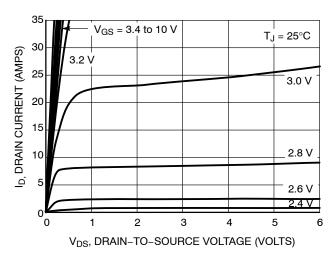
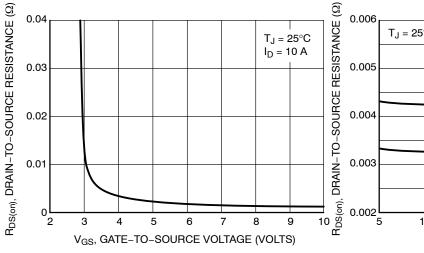


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



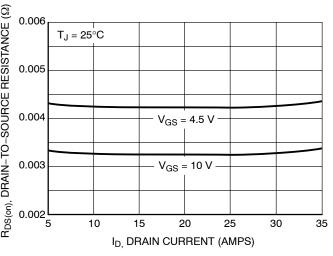
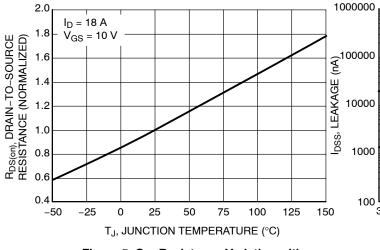


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



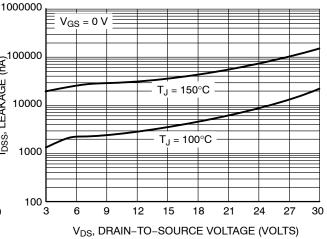


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES

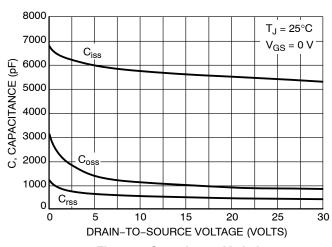


Figure 7. Capacitance Variation

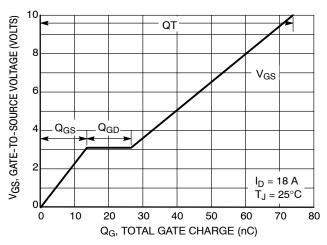


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

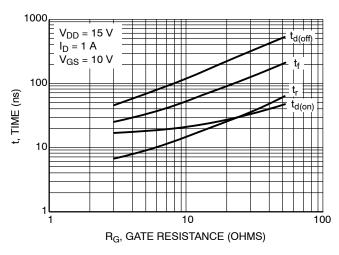


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

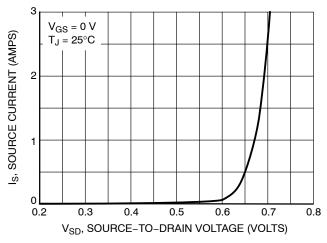


Figure 10. Diode Forward Voltage vs. Current

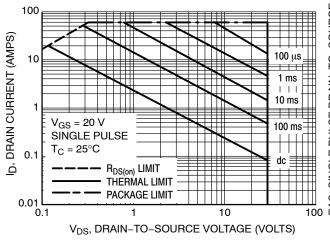


Figure 11. Maximum Rated Forward Biased Safe Operating Area

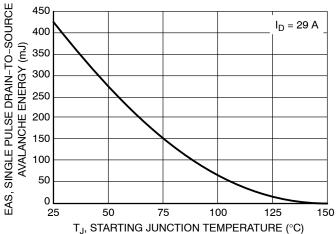


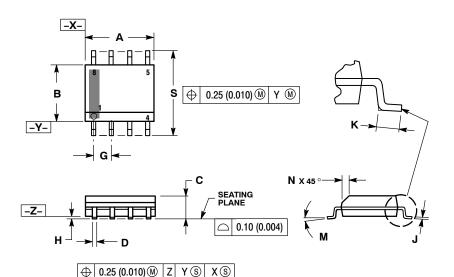
Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature





SOIC-8 NB CASE 751-07 **ISSUE AK**

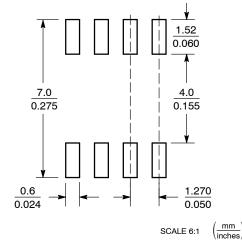
DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

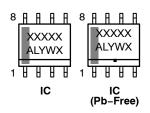
| | MILLIMETERS | | INC | HES | |
|-----|-------------|-------|-----------|-------|--|
| DIM | MIN | MAX | MIN | MAX | |
| Α | 4.80 | 5.00 | 0.189 | 0.197 | |
| В | 3.80 | 4.00 | 0.150 | 0.157 | |
| С | 1.35 | 1.75 | 0.053 | 0.069 | |
| D | 0.33 | 0.51 | 0.013 | 0.020 | |
| G | 1.27 | 7 BSC | 0.050 BSC | | |
| Н | 0.10 | 0.25 | 0.004 | 0.010 | |
| J | 0.19 | 0.25 | 0.007 | 0.010 | |
| K | 0.40 | 1.27 | 0.016 | 0.050 | |
| М | 0 ° | 8 ° | 0 ° | 8 ° | |
| N | 0.25 | 0.50 | 0.010 | 0.020 | |
| S | 5.80 | 6.20 | 0.228 | 0.244 | |

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot = Year = Work Week W

= Pb-Free Package

XXXXXX XXXXXX AYWW AYWW Ŧ \mathbb{H} Discrete **Discrete** (Pb-Free) XXXXXX = Specific Device Code

= Assembly Location Α = Year ww = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

| STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER | STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1 | STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1 | STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE |
|--|---|--|--|
| STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE | PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE | PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd | PIN 1. COLLECTOR, DIE #1 2. BASE, #1 |
| STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON | STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND | STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 | STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 9. DRAIN |
| STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN | STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN | STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 6. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON | STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1 |
| STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC | STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN | STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 | STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN |
| 3. V10UT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1 2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6 | STYLE 22: | 7. DRAIN 1 8. MIRROR 1 STYLE 23: PIN 1. LINE 1 IN 2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT | STYLE 24: PIN 1. BASE 2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE |
| STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT | STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC | STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN | STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN |
| STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1 | STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1 | | |

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